

IGBT module

SK 50 GD 12T4 Tp

Features

- One screw mounting module
- Solder free mounting with Press-Fit terminals
- Fully compatible with other SEMITOP® Press-Fit types
- Improved thermal performances by aluminium oxide substrate
- Trench4 IGBT technology
- CAL4F technology FWD
- Integrated NTC temperature sensor
- UL recognized, file no. E 63 532

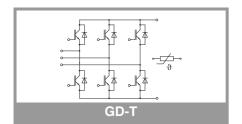
Typical Applications*

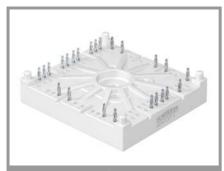
- Inverter up to 26kVA
- Typical motor power 15kW

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
IGBT 1				•		
V_{CES}	T _j = 25 °C		1200	V		
Ic	T _i = 150 °C	T _s = 25 °C	65	Α		
	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	T _s = 70 °C	50	Α		
I _C	T _j = 175 °C	T _s = 25 °C	72	Α		
		T _s = 70 °C	59	Α		
I _{Cnom}			50	Α		
I _{CRM}	$I_{CRM} = 3 \times I_{Cnom}$		150	Α		
V_{GES}			-20 20	٧		
t _{psc}	$V_{CC} = 800 \text{ V}$ $V_{GE} \le 15 \text{ V}$ $V_{CES} \le 1200 \text{ V}$	T _j = 150 °C	10	μs		
Tj		•	-40 175	°C		

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
Diode 1	•			'		
V_{RRM}	T _j = 25 °C		1200	V		
I _F	T _i = 150 °C	T _s = 25 °C	53	Α		
	1 _j = 150 C	T _s = 70 °C	40	Α		
IF	T 475.00	T _s = 25 °C	60	Α		
	T _j = 175 °C	T _s = 70 °C	48	Α		
I _{Fnom}		<u> </u>	50	Α		
I _{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		100	Α		
I _{FSM}	10 ms, sin 180°	, T _j = 150 °C	270	Α		
T _i		•	-40 175	°C		

Absolute Maximum Ratings						
Symbol	Conditions	Values	Unit			
Module			•			
I _{t(RMS)}	T _{terminal} = 100 °C, T _S = 60°C, per pin	40	Α			
T _{stg}		-40 125	°C			
V _{isol}	AC, sinusoidal, t = 1 min	2500	V			





SEMITOP® 4 Press-Fit

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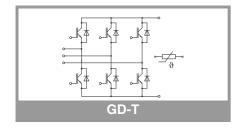
Typical Applications*

- Inverter up to 26kVA
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT 1						•
V _{CE(sat)}	$I_{\rm C} = 50 {\rm A}$	T _j = 25 °C		1.85	2.10	V
	V _{GE} = 15 V chiplevel	T _j = 150 °C		2.20	2.40	V
V_{CE0}	chiplevel	T _j = 25 °C		0.80	0.90	V
	Chipiever	T _j = 150 °C		0.70	0.80	V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		21	24	$m\Omega$
	chiplevel	T _j = 150 °C		30	32	mΩ
$V_{\text{GE(th)}}$	$V_{GE} = V_{CE}, I_C = 1.7$	mA	5	5.8	6.5	V
I _{CES}	$V_{GE} = 0 V$	T _j = 25 °C			0.67	mA
	V _{CE} = 1200 V			-		mA
C _{ies}	V _{CE} = 25 V V _{GF} = 0 V	f = 1 MHz		2.77		nF
Coes		f = 1 MHz		0.205		nF
C_{res}	I GE 01	f = 1 MHz		0.16		nF
Q_{G}	V _{GE} = -7V+15V	•		375		nC
R _{Gint}	T _j = 25 °C			4.0		Ω
t _{d(on)}	V _{CC} = 600 V	T _j = 150 °C		63		ns
t _r	$\begin{aligned} & I_{C} = 50 \text{ A} \\ & R_{G \text{ on}} = 32 \Omega \\ & R_{G \text{ off}} = 32 \Omega \\ & \text{di/dt}_{on} = 920 \text{ A/}\mu\text{s} \end{aligned}$	T _j = 150 °C		65		ns
E _{on}		T _j = 150 °C		8.3		mJ
t _{d(off)}		T _j = 150 °C		521		ns
t _f	$di/dt_{off} = 920 \text{ A/}\mu\text{s}$	T _j = 150 °C		80		ns
E _{off}	$V_{GE \text{ neg}} = -7 \text{ V}$ $V_{GE \text{ pos}} = 15 \text{ V}$	T _j = 150 °C		5		mJ
$R_{th(j-s)}$	per IGBT			0.65		K/W

Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
Diode 1	·					•	
V_{F}	I _F = 50 A	T _j = 25 °C		2.22	2.54	V	
	chiplevel	T _j = 150 °C		2.18	2.50	V	
V_{F0}	chiplevel	T _j = 25 °C		1.30	1.50	V	
		T _j = 150 °C		0.90	1.10	V	
r _F	chiplevel	T _j = 25 °C		18	21	mΩ	
		T _j = 150 °C		26	28	mΩ	
I _{RRM}	I _F = 50 A	T _j = 150 °C		30		Α	
Q _{rr}	$\begin{aligned} &\text{di/dt}_{\text{off}} = 920 \text{ A/}\mu\text{s} \\ &\text{V}_{\text{GE}} = -7 \text{ V} \\ &\text{V}_{\text{CC}} = 600 \text{ V} \end{aligned}$	T _j = 150 °C		7.2		μC	
Err		T _j = 150 °C		2.15		mJ	
R _{th(j-s)}	per diode			0.97		K/W	

Characteristics						
Symbol	Conditions	min.	typ.	max.	Unit	
Module						
Ms	to heatsink	2.5		2.75	Nm	
W	weight		60		g	



Characteristics							
Symbol	Conditions	min.	typ.	max.	Unit		
Temperature Sensor							
R ₁₀₀	T _r = 100 °C		493 ± 5%		Ω		
B _{100/125}	$R_{(T)} = R_{100} exp[B_{100/125}(1/T-1/T_{100})]; T[K];$	3550 ±2%		К			

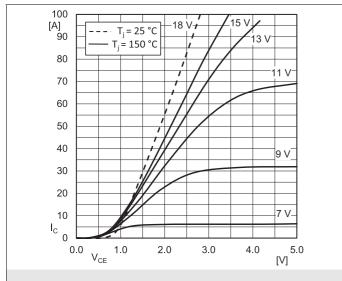


Fig. 1: Typ. IGBT1 output characteristic, incl. R_{CC'+ EE'}

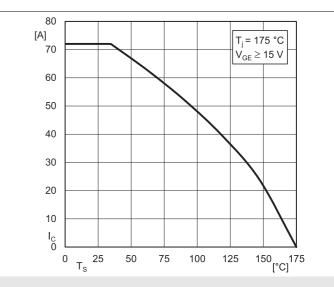


Fig. 2: Typ. rated current vs. temperature $I_C = f(T_S)$

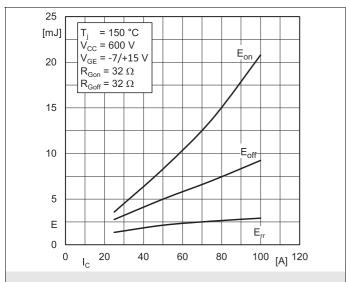


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

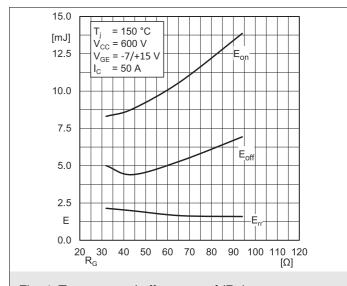


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

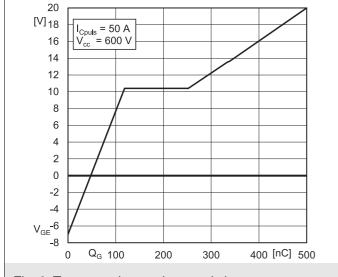


Fig. 6: Typ. gate charge characteristic

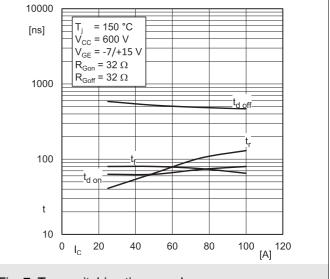
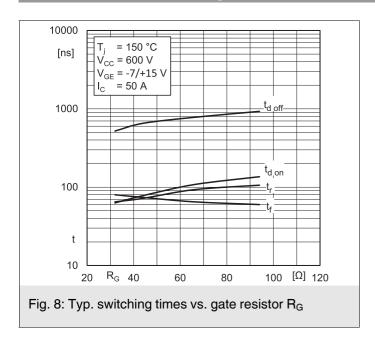


Fig. 7: Typ. switching times vs. I_C



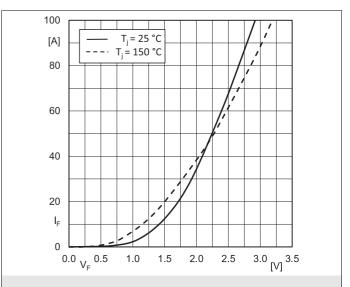
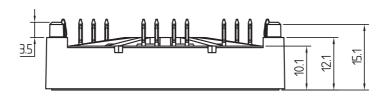
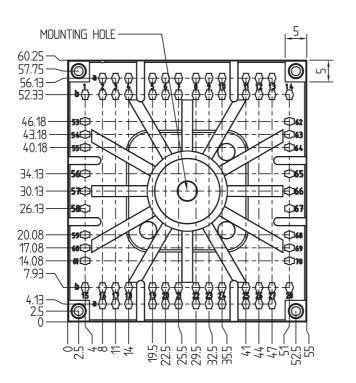


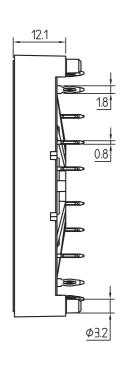
Fig. 10: Typ. CAL diode forward charact., incl. $R_{\text{CC'+}\,\text{EE'}}$

dimensions in mm

tolerance system: ISO 2768-m







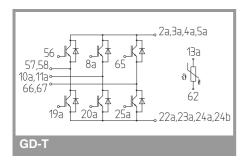
Suggested drilled hole diameter for terminal pins in the circuit board:

minimum: 1.575mmtypical: 1.6mmmaximum: 1.625mm

Suggested hole diameter for the mounting pins in the circuit board: 3.6mm

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SEMITOP 4 Press-Fit



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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